

Reuse and verification of equipment for the ISO 7637 standard

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Master of Science Thesis in Electrical Engineering

Reuse and verification of equipment for the ISO 7637 standard:

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Abstract

If your thesis is written in English, the primary abstract would go here while the Swedish abstract would be optional.

Acknowledgments

TODO

Linköping, Maj 2019
Jonatan Gezelius

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Notation

NÅGRA MÄNGDER

Notation	Betydelse
$\mathbb{N}$	Mängden av naturliga tal
$\mathbb{R}$	Mängden av reella tal
$\mathbb{C}$	Mängden av komplexa tal

ABBREVIATIONS

Abbreviation	Description
ARMA	Auto-regressive moving average
PID	Proportional, integral, differential (regulator)
DUT	Device Under Test

1

Introduction

The ISO 7637 standard, *Road vehicles – Electrical disturbances from conduction and coupling*, and ISO 16750, *Road vehicles – Environmental conditions and testing for electrical and electronic equipment*, are international standards that apply to products in road vehicles with a nominal supply voltage of 12 V or 24 V. The standards states, here put in a very condensed form, that the product shall withstand a sufficient amount of disturbances applied to its power supply. The reason for this is that there can be many voltage surges and much noise in a vehicle's power supply lines. In general, the source of disturbances and noise in a vehicle origins from inductance in other devices connected to the power line, the cables and the vehicles alternator in combination with switching of loads or the supply. [? ?]

To test if a product comply with this standard, there is equipment which simulates different events on the power supply. The standard defines the different scenarios, raise and fall times of test pulses, repetition times etc. It also defines the functional requirements of the equipment during these tests for what is considered a passed or a failed test. [? ?]

1.1 Motivation

The standard defines all the timing requirements that must be met, and also specifies the load conditions for which the requirements apply [?]. From time to time the standards are revised, which may alter the requirements form the previous versions of the standard. New equipment is guaranteed by its manufacturer to do

the tests according to the latest standard, as long as all the maintenance instructions are followed which might include sending the equipment in for calibration and service. New equipment cost lots of money amount of money and might not even be affordable by smaller test labs, and can thus inhibit labs from performing tests for this standard.

An appealing alternative would be the possibility to reuse the test equipment that was used along with the older revision of the standard, as long as it is capable of performing sufficient tests reliable. For this to be of any value the test equipment must be verified in some way to be able to guarantee that the tests are performed according to the new standard.

The old ISO 7637-2:2004 standard got revised to 7637-2:2011 and some parts were

1.2 Aim

The goal of this work is to investigate the potential of reusing test equipment made for an old standard, with the newer revised version of that standard, and how to assure that the test results are reliable.

The verification of the system is desired to be automated. This automated verification procedure is also part of the goal.

1.3 Research questions

The following questions will be answered in this paper:

- Can test equipment made for ISO 7637-2:2004, be used for testing compliance against ISO 7637-2:2011, the newer version of the standard?
- If it can; What considerations must be made to allow for automating the test and verification process?
- If it can't; What causes the failure, and what possible fixes can be made to make the equipment usable for the newer standard?

1.4 Delimitations

This paper only compares the standard ISO 7637-2:2004 to ISO 7637-2:2011 and ISO 16750-2:2012, because these are the most recent versions of the standards.

This paper only considers Pulse 1, Pulse 2a, Pulse 3a, Pulse 3b and Load dump A. The main reason being that these are the pulses that the available equipment can generate, but also that these pulses share many properties and the method of analysing them will probably be very similar.

This paper only considers the following test equipment for the real implementation that is available for this project:

Model	Description
EFT 200A	Burst generator
MPG 200B	Micropulse generator
LD 200B	Load dump generator
CNA 200B	Connection Network

TODO

TODO:
Mention the standard
also addresses
emission, but
that the report
only focuses on
immunity

1.5 Report structure

TODO

TODO:
fyll i upplägg när de
väl är klart

2

Theory

This chapter introduces the theory and facts that are related to this project. It describes the necessary parts of the ISO standards, measurement theory and analysis of acquired data.

TODO

TODO:
ta bort denna todo

2.1 Previous research

No previous research relevant to the reuse of test equipment was found. Though there is research available on smaller specific topics that are covered by this project, such as measurement techniques and curve fitting. Such findings are used in this theory chapter.

2.2 ISO standards

The ISO organisation, International Organization for Standardization, was founded in 1947 and has since published more than 22500 International Standards. ISO standards does not only cover the electronic industry, but almost every industry. The purpose of the standards is to ensure safety, reliability and quality of products in a unified way, making international trade easier. The name ISO comes from the Greek word *isos*, which means *equal*. [1]

The standards are developed and maintained by Technical Committees consisting of, amongst others, experts in the area that the standard [2]. A new standard is only developed when there exists a need for this from the industry or other groups that may require it [3]. Existing standards are automatically scheduled for review five years after its last publication, but can manually be reviewed before that time by the committee [4]. During the review process, it will be decided if the standard is still valid, need to be updated or if it should be removed [4].

The naming convention used for ISO standards is of the form *number-part:year*, where the *number* is the identifier to the unique ISO standard, *part* denotes the part of the standard if it is divided into several parts and *year* is the publishing year. For example, the name *ISO 7637-2:2011* refers to part 2 of the ISO 7637 standard published in 2011, whilst *ISO 7637-2:2004* would refer to an earlier version of the exact same document published in 2004.

To get hold of a copy of a standard, one need to buy it from ISO or one of its retailers. [?]]

2.3 ISO 7637 and ISO 16750

TODO The ISO 7637 standard, Road vehicles — Electrical disturbances from conduction and coupling, concerns the electrical environment in road vehicles. The standard consists of, at the time of writing, four parts.

Part 1, *Definitions and general considerations*, defines some abbreviations and technical terms that are used throughout the standard. It also describes the scope of where the standard is intended to be applied. [5]

Part 2, *Electrical transient conduction along supply lines only*, defines the test procedures related to disturbances that are carried along the supply lines of a product. Both emission, disturbances created by the DUT, and immunity, the DUT's capability to withstand disturbances, are covered. This part defines the test pulses, and the verification of the same, that are of interest to this project. [6]

Part 3, *Electrical transient transmission by capacitive and inductive coupling via lines other than supply lines*, defines immunity tests against disturbances on other interfaces than the power supply. It focuses on test setups and different ways of coupling the signals. [7]

Part 5, *Enhanced definitions and verification methods for harmonization of pulse generators according to ISO 7637*, proposes an alternative verification method of the test pulses defined in ISO 7637-2. The main difference from the method described in ISO 7637-2 is that U_A should not only be 0 V during the verification, but also be set to U_N . This will not be considered deeply in this report, since it is only a proposal and makes the verification equipment more difficult. [8]

TODO:
fundera på uppdelningen av stycken och underrubriker här, och allmän formattering

The ISO 16750, *Road vehicles – Environmental conditions and testing for electrical and electronic equipment*, concerns different environmental factors that a product might face in a vehicle, such as mechanical shocks, temperature changes and acids. Part 2, *Electrical Loads*, of the standard deals with some electrical aspects that was previously part of the ISO 7637 standard. This is the only part of ISO 16750 that will be considered. [9?]

2.4 Test pulses

All test pulses defined in ISO 7637 and ISO 16750 are supposed to simulate events that can occur in a real vehicle's electrical environment, that products must be able to withstand. The properties of these test pulses are well defined, to allow for unified testing regardless of which test lab that performs the test. In the real world, however, the disturbances might of course differ from the test pulses since a real case environment is not controlled. [6, 9, 10]

The test pulses of interest defined in ISO 7637 are denoted *Test pulse 1*, *Test pulse 2a*, *Test pulse 3a* and *Test pulse 3b*. The test pulse of interest defined in ISO 16750 is denoted *Load dump Test A*. There are more pulses and tests defined in these standards, but those are not in the scope of this thesis.

The general characteristics in common for all pulses are the surge voltage U_s , the rise time t_r , the pulse duration t_d and the internal resistance R_i . For pulses that are supposed to be applied several times, t_1 usually denotes the time between two consecutive pulses.

An important note to make is that the definition of the surge voltage, U_s , differs in ISO 7637 and ISO 16750 as seen in ??.

TODO

TODO:
Bild med kurvornas parametrar, både ISO standardernas definitioner

2.4.1 Test pulse 1

This pulse simulates the event of the power supply being disconnected to open, while the DUT is connected to other inductive loads. The other inductive loads will generate a voltage transient of reversed polarity, trying to maintain the current that was previously flowing through it.

In the standard there are two additional timing associated to this pulse, t_2 and t_3 , which are defining the disconnection time for the power supply during the voltage transient. In practice t_3 can be very short, specified to less than 100 μ s, and the step seen in ?? might be too short to be clearly distinguishable.

TODO

2.4.2 Test pulse 2a

This pulse simulates the event of a load, parallel to the DUT, is disconnected. The inductance in the wiring harness will then generate a positive voltage transient trying to maintain the current that was previously flowing through it.

TODO

2.4.3 Test pulse 3a and 3b

Test pulse 3a and 3b simulates transients “which occur as a result of the switching process” as stated in [6]. The formulation is not very clear, but is interpreted and explained by Frazier and Alles [10] to be the result of a mechanical switch brekaking an inductive load. These transients are very short, compared to the other pulses, and the repetition time is very short. The pulses are sent in bursts, grouping a number of pulses together and separating groups by a fixed time.

These pulses contain high frequency components, up to 100 MHz, and special care must be taken when running tests with them as well as when verifying them.

TODO

2.4.4 Load dump Test A

The Load dump Test A simulates the event of disconnecting a battery that is charged by the vehicles alternator, the current that the alternator is driving will give rise to a long voltage transient.

This pulse has the longest duration, t_d , of all the test pulses. It also has the lowest internal resistance. These properties makes it capable of transferring high energies into a low impedance DUT.

Prior to 2011, the Load dump Test A was part of the ISO 7637-2 standard under the name *Test pulse 5a*. The voltages specified for U_s was in the older standard, ISO 7637-2:2004, defined relative to the DC offset voltage U_A . In the newer standard ,ISO 16750-2:2012, U_s is defined as the absolute peak voltage including U_A .

TODO

2.4.5 Test setup

During a test, the nominal voltage is first applied between the plus and minus terminal of the DUT's power supply input, then a series of test pulses are applied between the same terminals. The pulses are repeated at specified intervals, t_1 , as depicted in Figure 2.2. *TODO*.

TODO:
Snygg bild på uppkoppling och kopplingsnätverk.

2.4.6 Mathematical description

All of the test pulses applied to the vehicle equipment can individually be described mathematically by variations of the double exponential function shown in Equation 2.1 and Figure 2.1. The properties of interest, the ones which are specified in the standards, are the surge voltage U_s , the rise time t_r , the duration t_d and the repetition time t_1 . [6]

How k , α and β are related to these properties will be described in more detail in ??.

TODO

TODO:
Tryck ihop bilderna och gör dem lite mindre

$$u(t) = k(e^{\alpha t} - e^{\beta t}) + U_A \quad (2.1)$$

2.4.7 Verification

The test pulses are to be verified before they are applied to the DUT. The voltage levels and the timings are to be measured, with and without a matched load attached $R_L = R_i$. The standard omits the rise time constraint when the load is attached, except for pulse 3a and 3b. [6]

The verification is to be conducted with U_A set to 0. There is, however, a proposal to set U_A to the actual nominal voltage during the verification process, as the behaviour of the pulse generators has proven differ in this case [8]. In this project $U_A = 0$ will be used.

The limits, and tolerances, for the pulses are summarised in Table 2.1. The matched loads are to be within 1% of the nominal value. [6]

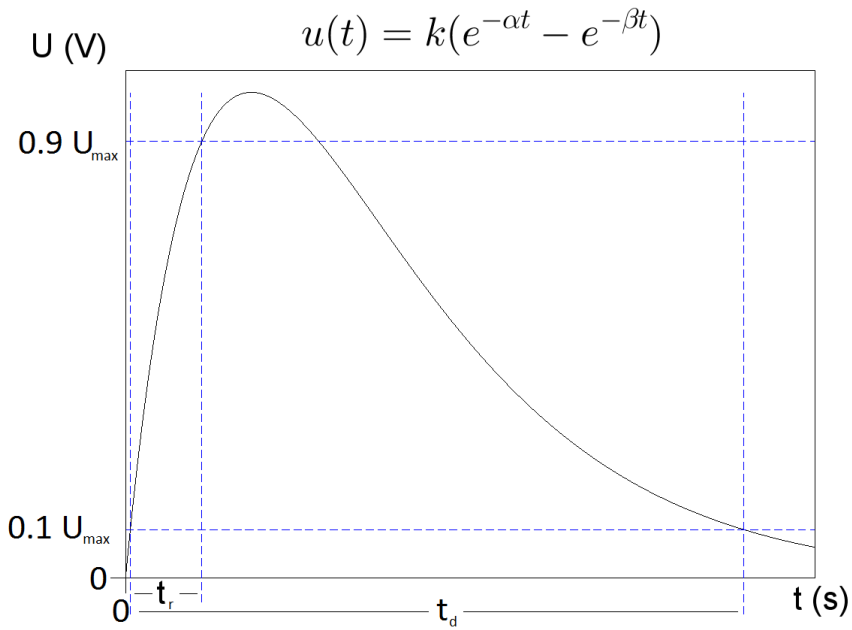


Figure 2.1: The rise time is defined as the time elapsed from 0.1 to 0.9 times the maximum voltage on the rising edge of the function. The duration is defined as the time from 0.1 times the maximum voltage on the rising edge, back to the same level of the falling edge.

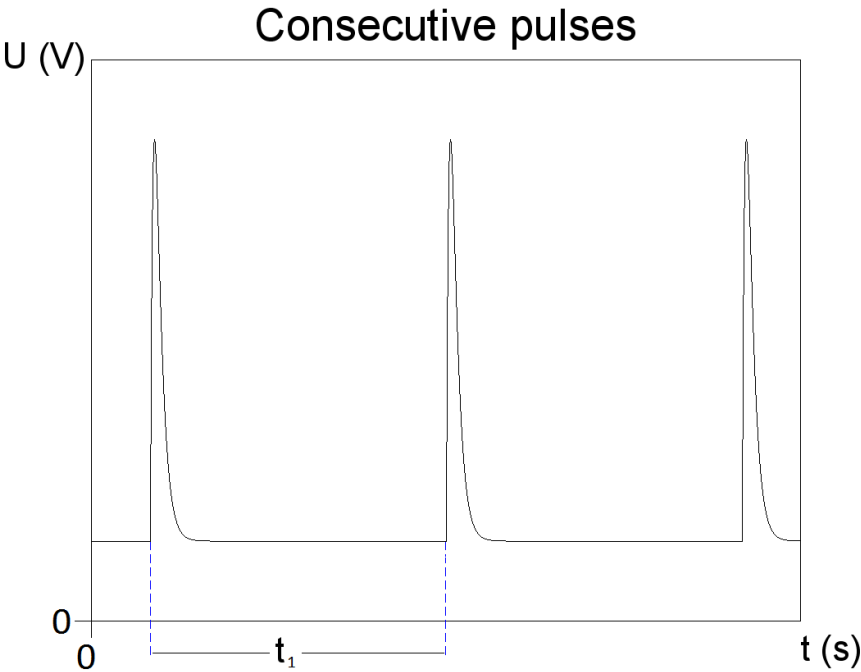


Figure 2.2: The repetition time is defined as the time between two adjacent rising edges, measured at 0.1 times the maximum pulse voltage.

Pulse	Match resistor (Ω)	Limits		
		U_S (V)	t_d (s)	t_r (s)
Pulse 1, 12 V, Open	10	$[-110, -90]$	$[1.6, 2.4]$ m	$[0.5, 1]$ μ
Pulse 1, 12 V, Matched		$[-110, -90]$	$[1.6, 2.4]$ m	$[0.5, 1]$ μ
Pulse 1, 24 V, Open		$[-660, -540]$	$[0.8, 1.2]$ m	$[1.5, 3]$ μ
Pulse 1, 24 V, Matched	50	$[-660, -540]$	$[0.8, 1.2]$ m	$[1.5, 3]$ μ
Pulse 2a, Open	2	$[67.5, 82.5]$	$[40, 60]$ μ	$[0.5, 1]$ μ
Pulse 2a, Matched		$[67.5, 82.5]$	$[40, 60]$ μ	$[0.5, 1]$ μ
Pulse 3a, Open (1k)		$[-220, -180]$	$[105, 195]$ n	$[3.5, 6.5]$ n
Pulse 3a, Match	50	$[-120, -80]$	$[105, 195]$ n	$[3.5, 6.5]$ n
Pulse 3b, Open (1k)	50	$[180, 220]$	$[105, 195]$ n	$[3.5, 6.5]$ n
Pulse 3b, Match		$[80, 120]$	$[105, 195]$ n	$[3.5, 6.5]$ n
Load dump A, 12 V, Open		$[90, 110]$	$[320, 480]$ m	$[5, 10]$ m
Load dump A, 12 V, Matched	2	$[90, 110]$	$[320, 480]$ m	$[5, 10]$ m
Load dump A, 24 V, Open	2	$[180, 220]$	$[280, 420]$ m	$[5, 10]$ m
Load dump A, 24 V, Matched		$[180, 220]$	$[280, 420]$ m	$[5, 10]$ m

Table 2.1: These are all of the verifications that needs to be made before each use of the equipment, along with the limits for each case.

2.5 Differences from ISO 7637:2004 to ISO 7637:2011 and ISO 16750:2012

Since the equipment used the project is designed for the older version of the standard, ISO 7637-2:2004 and possibly even ISO 7637-1:1990 together with ISO 7637-2:1990, the differences of importance between these will be presented in this chapter to see what parameters might be a problem for the older equipment to fulfil.

One of the most notable differences is the removal of a test pulse from ISO 7637-2 that was called *Pulse 5a* and *Pulse 5b*, this was instead introduced to the ISO 16750-2 under the name *Load dump A* and *Load dump B*.

2.5.1 Definitions

Since there are now two different standards, ISO 7637 and ISO 16750, that are describing the pulses some differences in definitions have been introduced.

TODO

U_S

For pulse 1, 2a, 3a and 3b: $U_{TOP} - U_N$

For Load dump A: U_{TOP}

TODO:
Snyggga till presentationen av definitionerna

U_A

For pulse 1, 2a, 3a and 3b: $13.5 \pm 0.5 \text{ V}$, $27 \pm 1 \text{ V}$ [?]

For Load dump A: $14 \pm 0.2 \text{ V}$, $28 \pm 0.2 \text{ V}$ [?]

2.5.2 Tolerances

Some of the allowed ranges on the pulses parameters has changed compared to the older version of the standard.

TODO

TODO:
Gör snygga tabeller

Pulse 1 Old, 12V: $U_S - 75 - - - 100 \text{ V}$ Old, 24V: $U_S - 450 - - - 600 \text{ V}$

New, 12V: $U_S - 75 - - - 150 \text{ V}$ New, 24V: $U_S - 300 - - - 600 \text{ V}$

Pulse 2a Old: $U_S 37 - - 50 \text{ V}$

New: $U_S 37 - - 112 \text{ V}$

Pulse 3a and Pulse 3b Old, 12V: $|U_S| 112 - - 150 \text{ V}$ Old, 24V: $|U_S| 150 - - 200 \text{ V}$

New, 12V: $|U_S| 112 - - 220 \text{ V}$ New, 24V: $|U_S| 150 - - 300 \text{ V}$

Old: $t_r 100 - - 200 \mu\text{s}$

New: $t_r 105 - - 195 \mu\text{s}$

Load dump A No change, other than the definitions.

2.5.3 Tolerances for verification

Pulse 1

Old, 24V, matched: $U_S - 300 \pm 30 \text{ V}$

New, 24V, matched: $U_S - 300 \pm 60 \text{ V}$

Pulse 2a

Old, open: $U_S 50 \pm 5 \text{ V}$, matched $U_S 25 \pm 5 \text{ V}$

New, open: $U_S 75 \pm 7.5 \text{ V}$, matched $U_S 35.5 \pm 7.5 \text{ V}$

Pulse 3a and Pulse 3b

No change.

Load dump A No change, but according to print (or thought) error:

Old, 12 V, open: $U_S 100 \pm 10$ V, matched $U_S 50 \pm 10$ V

New, 12 V, open: $U_S 87 \pm 10$ V, matched $U_S 37 \pm 10$ V **NOTE, this can't be true**

Old, 12 V, open: $U_S 200 \pm 20$ V, matched $U_S 100 \pm 10$ V

New, 12 V, open: $U_S 172 \pm 20$ V, matched $U_S 72 \pm 20$ V **NOTE, this can't be true**

2.6 Resistors at high frequencies

<https://www.edn.com/design/components-and-packaging/4423492/Resistors-aren-t-resistors>

<https://www.vishay.com/docs/60107/freqresp.pdf>

2.7 Measurement

There are several measurement methods needed during the project. To verify the test pulses, voltage has to be measured over time. To verify the dummy loads, resistance has to be measured. To verify the attenuators, the magnitude response has to be measured. This chapter describes the necessary measurement theory required for this project.

2.7.1 Resistance

The circuit designers companion p.99

2.7.2 High Voltage

The highest voltage that can be generated by the pulse generators is 1500 V, which is higher than any of the standards require but will serve as the design goal for the verification equipment. This is a higher voltage than most acquisition devices can measure without the use of external attenuators [?].

Resistive attenuators.. *TODO*

2.7.3 Bandwidth and rise time

The shortest rise time is xxx ns, which can roughly be compared to yyy MHz. [?]

The relationship and requirements, addition of rise time limitations etc Combined rise time [?].

high speed digital design 83

2.7.4 Oscilloscope and probes

An oscilloscope measures voltage over time, using voltage probes.

The oscilloscope has properties bandwidth...

The probe also has properties..

Commercial probes are expensive

2.7.5 Measurement errors

Put good theory here

2.7.6 RF Attenuators

Linearity, tolerances, power, combinations of resistors, impedances

2.7.7 Tolerances and maximum ratings

Resistors, Power, Voltages, surges, Relays, isolation, dielectric strength

2.8 Analysis

The data points from the measurement must be processed and evaluated to determine if the measured pulse is within the specified limits. There are several techniques to accomplish this, which have different advantages.[?]

2.8.1 Goodness??

TODO:
Någotting om vad
som anses bra

TODO

2.8.2 Curve fitting?

TODO:
Läs på om ämnet
och se ifall det kan
vara rimligt

TODO

2.8.3 Max/min limits?

TODO:
Användandet av
max/min-fönster

TODO

2.8.4 Parameter extraction?

TODO:
Detta är nog ett
påhittat ord, kanske
menar jag curve fit-
ting?

TODO

2.8.5 Evaluation/simulation/robustness

TODO:
Jämför och evaluera
de två eller tre
metoderna med
hänseende till
vad som står i
"goodness"

TODO

Essentially an embedded high voltage probe.

Bra böcker

High frequency content

Measurement & Instrumentation Principles, Alan S Morris

High-Voltage Engineering and Testing, 3rd Edition, Chapter 15 - Basic Measuring Techniques

Handbook of Measuring System Design, Peter H Sydenham and Richard Thorn

Artiklar om högspänningsmätning

High Voltage Measurements Using Slab Coupled Optical Sensors (SCOS)

LeGrand Shumway, Nikola Stan, Freddy Seng, Rex King, Richard Selfridge, Stephen Schultz Department of Electrical & Computer Engineering, Brigham Young University, Provo, Utah 84602, USA

High frequency high voltage probe embedded into an extremely low inductivity high voltage supply connection D. Ketel, H. Hirsch, M. Malek University of Duisburg-Essen, Bi smarckstr. 81, 47057 Duisburg, Germany, <http://www.ets.uni-due.de> Tel: +49(0) 203 379 3789, email: daniel.ketel@uni-due.de

Optical measurement of current and voltage on power systems AJ. Rogers

Application of the Pockels Effect to High Voltage Measurement Fei Long Jianhuan Zhang Chunrong Xie Zhiwei Yuan Mechanical Electrical Engineering Department, Xiamen University, Xiamen, 361005 China

Curve fitting och Double exponential pulse function

Shape Properties of Pulses Described by Double Exponential Function and Its Modified Forms

On the Design and Generation of the Double Exponential Function S. C. Dutta Roy and D. K. Bhargava

2.9 Instrumentation and control

The following chapter describes the different instruments that were used, and their control interfaces.

2.9.1 GPIB

IEEE-488, or GPIB which it is often called, is a parallel bus interface. It is mainly used to interconnect lab instrumentation such as multimeters, signal generators and spectrum analyzers. *TODO*

TODO:
fyll på och hitta källor, lägg in bild på interface

2.9.2 Tektronix TDS7104 Oscilloscope

The oscilloscope that is available is a Tektronix TDS7104, with specifications as seen in ???. It has GPIB interface and TekVISA GPIB, an API for sending GPIB commands over ethernet, available for remote control.

TODO

2.9.3 EM Test MPG 200 Micropulse generator

The MPG 200 is used to generate *Test pulse 1* and *2a*. MPG is an abbreviation for *MicroPulse Generator*. The instrument is designed to generate test pulses according to the older ISO 7637-2:1990 version, but the parameters can be adjusted to comply with the new ISO 7637:1990 standard.

TODO

2.9.4 EM Test EFT 200 Burst generator

The EFT 200 is used to generate *Test pulse 3a* and *3b*. EFT is an abbreviation for *Electrical Fast Transient*. The instrument is designed to generate test pulses according to the older ISO 7637-2:1990 version, but the parameters can be adjusted to comply with the new ISO 7637:1990 standard.

TODO

2.9.5 EM Test LD 200 Load dump

The LD 200 is used to generate *Load dump Test A*. LD is an abbreviation for *Load Dump*. The instrument is designed to generate test pulses according to the older ISO 7637-2:1990 version, but the parameters can be adjusted to comply with the new ISO 16750:2012 standard.

TODO

2.9.6 EM Test CNA 200 Coupling Network

The SNA 200 is a coupling network, used to multiplex the pulse generators into one box. It contains several relays to select the appropriate generator output.

The SNA 200 has one interface for each pulse generator, but no interface for a computer. It is automatically controlled by the pulse generators.

TODO

TODO:
Lägg in bild p
utrustning, och
tabell med data

2.9.7 Rohde & Schwarz ZVL13

The ZVL13 is a vector network analyzer. It is, in this project, used to measure the magnitude and phase response between its two ports.

TODO

TODO:
Lägg in bild p
utrustning, och
tabell med data

2.9.8 PAT 50 and PAT 1000

3

Methods

This chapter covers the methodologies used during the project. To man dude!
TODO

TODO:
la bort detta

3.1 Prestudy

During the project efforts were made to find relevant research using Linköping University Library's¹ and Google Scholar's² search engines. Among the keywords used in searching were *verification equipment*, *test equipment*, *automatic test*, *automatic verification*, *iso equipment*, *electrical verification*, *curve fitting*, *double exponential function*, ,

TODO

TODO:
Skriv färdigt nyck
elordsdelen

Since the equipment intended for this project was untested before the project start, the first step was to hook it up and make some initial measurements to be able to decide the continuation of the project.

If the equipment seem to be mostly in line with the new standard requirements, the project plan was to go along the following path:

1. Investigate test architectures suitable for automatic testing and verification.

¹<https://liu.se/en/library>

²<https://scholar.google.se/>

2. Design any utilities needed for the test and verification setup.
3. Implement the test architecture and any necessary utilities.
4. Measure and evaluate the system and the utilities.

If the equipment proved to deviate to much from the standard requirement, the project should go along the following path:

1. Investigate possible causes and fixes for the failure.
2. Design any utilities needed for the equipment to pass.
3. Implement these utilities.
4. Measure and evaluate the system with these utilities manually.

In either case, the following tasks should be considered if there is time:

1. Investigate possible methods, or algorithms, that can automatically verify the pulse shapes and parameters.
2. Implement a number of these methods.
3. Evaluate these methods.

3.2 Initial measurement of the performance of the old equipment

To decide the forthcoming of the project, the equipment first had to be checked for its performance and if it is within the limits for use with the newer standard. Because there is no dummy loads available at this point of the project, only open load measurements could be done.

With exception for Pulse 3a and Pulse 3b, all of these pulses were measured with the use of the high voltage differential probe described in ???. The pulses are measured both directly on each generator connected according to ??? and also through the coupling network CNA 200, as depicted in ???. *TODO* Pulse 3a and Pulse 3b was measured using the attenuators described in ??? connected according to ???. Thanks to the 50-ohm attenuator this pulse could be measured in its matched state. The measurement in open state is a compromise, since there was no such attenuator available, and was made into a 1000-ohm attenuator instead.

3.3 Test architecture

Alternatives and choices. Try finding articles on human error maybe. Make plenty of nice figures.

The total number of tests needed to verify the testing equipment before each product test is 14, according to Table 2.1. There are in total three different values for dummy loads, in practice these will be represented by three different high power dummy loads and two high frequency attenuators for pulse 3a and pulse 3b.

The following test architectures were considered, together with the external supervisor at the company. In the end the 3rd alternative was chosen, as explained in section 4.3. To design Alternative 3 some utilities needs to be designed, namely:

- Relay box, the fixture with embedded attenuators that are to be attached to the front of the CNA.
- Match box, the dummy loads with some relays to be able to switch between them.

Additionally there needs to be some sort of measurement fixture for evaluating the verification equipment.

3.3.1 Alternative 1 – Human assisted

The test can be performed semi-automatically by means of the existing equipment complemented by some dummy loads and, in the same manner the manual performance tests were executed. A computer could control the equipment and compare the results, by the assist of a human that can make the necessary reconections between the tests.

The main advantage of this is that it would probably require the least amount of time for development of the automation software. It also doesn't need any extra hardware except from the dummy loads needed to do the verification.

The biggest disadvantage is that it would be very cumbersome to perform and also very prone to human error. If the verification list is studied carefully one can minimise is to five reconnections after the initial connections are made, for example in the following order: No load, 2 Ω , 10 Ω , 50 Ω low frequency, 50 Ω high frequency, 1 k Ω high frequency.

3.3.2 Alternative 2 – Fully automatic rig external attenuators

To accurately measure Pulse 3a and Pulse 3b, the probes should be attached as close as possible to the generator because of the high frequency, to avoid influence of the connecting wires. This could be accomplished by the means of a fixture that is attached directly to the generator, which can switch the pulses to the different loads or to the measurement outputs.

The dummy loads for all pulses, but Pulse 3a and Pulse 3b, will need to be put in a separate enclosure because of the power dissipation needed. The proposed architecture is depicted in ??.

The advantage of this method is that the verification can be performed fully automatically, except for the initial connection of the test rig. This also uses the commercially created attenuators that are already available.

The disadvantage to this setup is that the fixture needs to be designed, making the development costs greater. The fixture that attaches to the generator will expose high voltage on its measurement connectors, making it a safety hazard.

3.3.3 Alternative 3 – Fully automatic rig with embedded attenuators

To cope with the high voltage exposure, of alternative 1, the high frequency attenuators can be embedded inside the switching fixture, removing the need for high-voltage connectors. ??.

The advantage of this, on top of the advantages of alternative 2, is that there is no longer need for external attenuators and that the connectors will no longer expose high voltage.

The disadvantage of this would be that the embedded attenuators might prove difficult to design. They need to be accurate up to high frequencies, be tolerable to high voltage, dissipate the power necessary and also be electrically safe.

3.4 Design of dummy loads

Each dummy load must withstand the applied test pulses, and preferably the worst possible test pulse for the specific dummy load even though it might not be intended. The dummy loads must have a tolerance of 1 % or less and be non-inductive. [6]

The dummy loads consists of one or more resistors. When determining whether

the resistors withstands the test pulses, the parameters of interest are power dissipation, maximum voltage and maximum energy applied over time.

3.4.1 Components

At first the momentary worst case powers and voltages were calculated by hand, to the values seen in Table ???. But to find components that can handle these momentary powers proved very difficult, and it is not necessary since the pulse power is varying over time and the impulse voltage does not stress the components as much as a constant voltage would do.

One manufacturer of thick film resistors, namely Vishay, specifies its overload capability in a graph with energy over time in the datasheet, which was easier to compare against using LTSpice to simulate the energies for the different loads, according to ??. The simulated value was then divided by the value specified in the datasheet to get the minimum number of resistors required to share the load. Some possible combinations of available resistor values were considered to reach the desired load resistance, before the final configuration were decided according to ??.

TODO

The voltages used in the calculations are specified in Table ??, they are slightly higher than the specified voltages on the equipment to allow for some margins. The worst case voltage must always be tolerated to prevent arching or serious degrading of the components.

Dummy load (Ω)	Pulse	R_S (Ω)	Generator voltage (V)	Peak voltage (V)	Peak power (W)	Mean power (W)
2	Pulse 1	2	650	325	45 k	5
10	Pulse 1	2	650	600	5 k	5
50	Pulse 1	2	650	600	5 k	5
50	Pulse 1	2	650	600	5 k	5

Table 3.1: Calculated momentary worst cases for each dummy load.

TODO

TODO

TODO

TODO:
ltspice-bild på de tre olika dummy load sen

TODO:
Rätta till värdena tabellen!

TODO:
input worst case ta ble here

TODO:
input graph of en ergy

3.4.2 PCB

Since the dummy loads consists of many discrete resistors, it was decided to design a PCB to connect them. This also gives good mechanical control of the resistors and the possibility to design for good heat dissipation.

Because of the high voltages present on the board it was decided to keep a minimum of 3mm functional isolation creepage distance between all traces on the board, in line with the EN 60664-1 standard [11]. The board was perforated to allow for better air flow past the resistors. The mounting holes for the card was placed in a 105×105 mm square, allowing for a 120 mm fan to be mounted on top of the card using mounting hardware.

A two layer board was chosen, and all of the traces were mirrored on both layers to get as much conductive cross sectional area as possible, and thus lowering the resistance and voltage drop in the traces. The PCB was ordered with 60 μ m thick copper layer to further extend the cross sectional areas. The width of the traces for the 2 Ω load was chosen as wide as possible, since the pulse currents are the highest for this one. *TODO*

Both the circuit schematic and layout editing of the board were performed in the free EDA tool KiCad. Before ordering the PCB, it was printed in 1:1 scale and attached to a piece of card board. The card board was then populated with the components already at hand to ensure that the footprints are correct and that the placement of the components makes sense and does not collide.

TODO

3.4.3 Measurement

When the dummy loads had been assembled, their resistances were determined using four wire resistance measurement directly at the PCB's connection points, as seen in ?? . With this technique, one can neglect the resistance in the cables used for measuring which can have a significant affect when measuring low resistance loads [?].

3.5 Design of the switching fixture and embedded attenuators

The chosen implementation requires a fixture that switches and attenuators, which purpose is to switch the pulse to the desired attenuator or to the dummy load. It must be able to handle the momentary pulse energies and voltages.

TODO:
kolla så detta är sant

TODO:
Fin bild på design-process av PCB, säkerhetsavstånd etc

3.5.1 Attenuators

The target attenuation was decided to mimic the commercial attenuators, described in subsection 2.9.8, where the $50\ \Omega$ has an attenuation of 54.7 dB and the $1000\ \Omega$ has an attenuation of 60.1 dB.

Only Pulse 3a and Pulse 3b were considered when designing these attenuators, since all other test pulses will be coupled to the separate dummy load.

The two attenuators were implemented as Π -attenuators. The values for the attenuators were retrieved from an online calculator³, and then they were simulated in LTSpice to verify the values.

By dividing the attenuators into two Π -networks, the series resistance required will get a bit lower compared to realising them in a single Π -link. This is desirable because the parasitic capacitance, which is dependant of the resistor package and not the resistance, will influence a high value resistor at lower frequencies that it would on a low value resistor, as explained in section 2.6.

A resistor with high pulse power and high voltage properties had to be chosen. Vishay's CRCW-HP series fitted this description and were easily available.

When the ideal resistor values had been derived, the maximum power dissipation and maximum voltage for each resistor was retrieved by simulation. Based on this, the minimum number of discrete resistors needed to withstand the pulse power was calculated. In the same way the minimum number of series resistors to withstand the maximum pulse voltage was calculated. These numbers are presented in ??.

With the minimum number of discrete resistors needed for each ideal resistor known, a constellation of available resistor values was constructed to approximate the nominal value with as few resistors as possible.

The 54.7 dB attenuator was divided into two 27.35 dB Π attenuator links. When the closest values for the resistors had been chosen, using $56\ \Omega$ as shunt resistors and $56\ \Omega$ in series, the final attenuation was 53.66 dB for the two links according to the simulation, seen in ??. The input and output resistance was

Nice graphs.

The 60.1 dB attenuator was divided into one 27.35 dB Π attenuator links 32.75 dB. When the closest values for the resistors had been chosen, using $56\ \Omega$ as shunt resistors and $56\ \Omega$ in series, the final attenuation was 53.66 dB for the two links according to the simulation, seen in ??. The input and output resistance was subsection 5.2.1

³<https://chemandy.com/calculators/matching-pi-attenuator-calculator.htm>

3.5.2 Desired vs implemented (simulation)

Parasitic effects. (real life, back to simulation) *TODO*

3.5.3 PCB

TODO

3.5.4 Measurement

The stuff and things done when measuring the shitload yo. Also measured at the other point. Using oscilloscope bla. Hah.

3.6 Analysis

TODO:

kanske borde ligga under results?

TODO:

Fin bild på design-process av PVB, säkerhetsavstånd etc

4

Results

4.1 Prestudy

Since not much was known about the project at this time, it was difficult to find relevant papers on the topic of the standards. Most of the literature was found during the project as new problems was found along the way.

4.2 Initial measurement of the performance of the old equipment

As can be seen in Table 4.1 and Table 4.2, some values exceeded the limits (marked in red).

TODO Three of these values even exceeds the old standard's limits, thus indicating that the equipment should probably be usable with the new standard after some service or calibration. With this in mind, the course of the project will be targeted towards the design of an automated verification system, as described in ???. With such a verification equipment at hand, the calibration of the generators might be easier to perform as well.

TODO:
flytta till diskussion?

Pulse	Limits			Measured		
	U_S (V)	t_d (s)	t_r (s)	U_S (V)	t_d (s)	t_r (s)
Pulse 1, 12 V, Open	[-110, -90]	[1.6, 2.4] m	[0.5, 1] μ	-99.0	2.10 m	540 n
Pulse 1, 24 V, Open	[-660, -540]	[0.8, 1.2] m	[1.5, 3] μ	-630	1.18 m	2.6 μ
Pulse 2a, Open	[67.5, 82.5]	[40, 60] μ	[0.5, 1] μ	76.0	51.0 μ	750 n
Pulse 3a, Open (1k)	[-220, -180]	[105, 195] n	[3.5, 6.5] n	-202	163 n	5.2 n
Pulse 3a, Match	[-120, -80]	[105, 195] n	[3.5, 6.5] n	-104	134 n	5.0 n
Pulse 3b, Open (1k)	[180, 220]	[105, 195] n	[3.5, 6.5] n	202	208 n	5.1 n
Pulse 3b, Match	[80, 120]	[105, 195] n	[3.5, 6.5] n	102	166 n	5.0 n
Load dump A, 12 V, Open	[90, 110]	[320, 480] m	[5, 10] m	93.4	390 m	5.8 m
Load dump A, 24 V, Open	[180, 220]	[280, 420] m	[5, 10] m	190	365 m	5.2 m

Table 4.1: The initial manual measurements, measured directly at each generator's output.

Pulse	Limits			Measured		
	U_S (V)	t_d (s)	t_r (s)	U_S (V)	t_d (s)	t_r (s)
Pulse 1, 12 V, Open	[-110, -90]	[1.6, 2.4] m	[0.5, 1] μ	-99.2	2.00 m	450 n
Pulse 1, 24 V, Open	[-660, -540]	[0.8, 1.2] m	[1.5, 3] μ	-632	1.18 m	2.6 μ
Pulse 2a, Open	[67.5, 82.5]	[40, 60] μ	[0.5, 1] μ	76.0	50.0 μ	770 n
Pulse 3a, Open (1k)	[-220, -180]	[105, 195] n	[3.5, 6.5] n	-213	163 n	6.2 n
Pulse 3a, Match	[-120, -80]	[105, 195] n	[3.5, 6.5] n	-93.2	138 n	6.0 n
Pulse 3b, Open (1k)	[180, 220]	[105, 195] n	[3.5, 6.5] n	222	200 n	6.3 n
Pulse 3b, Match	[80, 120]	[105, 195] n	[3.5, 6.5] n	94.0	171 n	5.7 n
Load dump A, 12 V, Open	[90, 110]	[320, 480] m	[5, 10] m	93.2	394 m	5.8 m
Load dump A, 24 V, Open	[180, 220]	[280, 420] m	[5, 10] m	186	400 m	5.1 m

Table 4.2: The initial manual measurements on the equipment, including the CNA 200.

4.3 Test architecture

The 3rd alternative was chosen because of the convenience of a fully automatic system and because of the electrical safety that alternative 2 would pose.

4.4 Design of dummy loads

TODO: flytta till resultat
 The values measured are, presented in Table 4.3, are well within the 1 % specified by the standard [6].

Dummy load (Ω)	Measured R (Ω)	Tolerance (%)
2	2.004	0.2
10	9.973	0.27
50	49.954	0.09

Table 4.3: The measured resistance of the dummy loads.

4.5 Design of the switching fixture

4.6 Measurement

4.7 Analysis

5

Discussion

5.1 Results

5.2 Method

It was surprisingly difficult to find and choose appropriate components for the dummy load. The resistors had to tolerate extreme surges and the relays had to have high insulation voltages between the contacts.

5.2.1 Attenuators

During the project, the attenuation was considered as the voltage attenuation $att = 20 \log_{10} \left(\frac{V_{in}}{V_{out}} \right)$ dB. However, lots of information and many tools for RF applications, including the calculator used for the attenuators in this project, assume power attenuation $att = 10 \log_{10} \left(\frac{P_{in}}{P_{out}} \right)$ dB. The result of these two properties coincides when the input and output impedance, as well as the driving and loading impedance, are all the same.

The fact that these two ways of expressing attenuation could be mixed up was not noticed until very late in the project. Thus the values provided by the online attenuator tool did not give the desired results in the simulator, for the 1000Ω attenuator. This was at the time manually tweaked until the desired attenuation was acquired, but the out impedance was not considered during the tweaking

and ended thereby up being a bit mismatched for the next Π link.

There are infinitely many constellations to approximate the nominal value, in this project it was tried to use as few resistors as possible. This process was performed manually, since no suitable software for solving the problem was found. Thus the chosen constellations might not be optimal.

5.3 The work in a wider context

Ethical aspects

5.4 References

Source criticism

6

Conclusion

Sätt av ett kort kapitel sist i rapporten till att avrunda och föreslå rikningar för framtida utveckling av arbetet.

Besvara frågeställningen

Future work

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Appendix

A

Trista saker

Långa beräkningar brukar bli rätt trista...

Detta är ett appendix-kapitel. Jämför med appendixet i kapitel ??.

A.1 Bädda sängen

Den här beräkningen är så trista att vi kallar den *att bädda sängen*.

A.2 Diska

Den här beräkningen är så trista att vi kallar den *att diska*.

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 abbreviation, xiii

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 abbreviation, xiii

PID
 abbreviation, xiii